



<b>Search Notes</b>  	Application/Control No.  10825575	Applicant(s)/Patent Under Reexamination  HEINONEN ET AL.
	Examiner Kowalewski, Filip A	Art Unit 3736

Notes	Date	Examiner
Plus Search	8/16/2006	FAK
East Search	8/16/2006	FAK
IDS Search	8/16/2006	FAK
Inventor Search	8/16/2006	FAK
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<p><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10825575</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>HEINONEN ET AL.</p>
	<p>Examiner</p> <p>Kowalewski, Filip A</p>	<p>Art Unit</p> <p>3736</p>

Class	SubClass	Date	Examiner
600	300-301	8/17/2006	FAK
128	903-905	8/17/2006	FAK

U.S. Patent and Trademark Office	Part of Paper No.:
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